

**Notice of References Cited**

Application/Control No.

09/990,558

Applicant(s)/Patent Under  
Reexamination  
CHOI ET AL.

Examiner

John L. Shew

Art Unit

2616

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0025815	02-2002	Rune et al.	455/436
*	B	US-6,963,540 B2	11-2005	Choi et al.	370/252
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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**NON-PATENT DOCUMENTS**

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